

FILE 'HOME' ENTERED AT 09:32:16 ON 21 JUL 2005)

FILE 'INSPEC' ENTERED AT 09:32:38 ON 21 JUL 2005

L1 143 PERIPHER##### CIRCUIT
L2 170858 BOND#####
L3 47186 POROUS
L4 52766 (SWITCH##### OR DISPLAY) (P) CIRCUIT
L5 0 L1 AND L2 AND L3 AND L4
L6 36066 PERIP#####
L7 0 L6 AND L2 AND L3 AND L4
L8 0 L2 AND L3 AND L4
L9 23 L1 AND L4
L10 0 L2 AND L9

FILE 'CA' ENTERED AT 09:36:11 ON 21 JUL 2005

L11 0 L5
L12 36 L9
L13 0 L3 AND L12
L14 4 L12 AND L2

R 1 OF 4 CA COPYRIGHT 2005 ACS on STN

AN 142:269388 CA

ED Entered STN: 24 Mar 2005

TI Method for manufacturing liquid crystal display

IN Lee, Seong Hak

PA LG Philips LCD Co., Ltd., S. Korea

SO Repub. Korean Kongkae Taeho Kongbo, No pp. given

CODEN: KRXXA7

DT Patent

LA Korean

IC ICM G02F001-1337

CC 74-13 (Radiation Chemistry, Photochemistry, and Photographic and Other Reprographic Processes)

FAN.CNT 1

PATENT NO.	KIND	DATE	APPLICATION NO.	DATE
PI KR 2003094529	A	20031218	KR 2002-31227	20020604
PRAI KR 2002-31227		20020604		

CLASS

PATENT NO.	CLASS	PATENT FAMILY CLASSIFICATION CODES
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KR 2003094529	ICM	G02F001-1337
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AB A method for manufacturing a liquid crystal **display** is provided to reduce static electricity generated in a rubbing process, thereby preventing **peripheral circuit** part from being short. Alignment films are applied on active areas of an upper substrate and a lower substrate. Masks are placed on the upper substrate and the lower substrate, having the active areas as aperture parts. The aperture parts of the masks are rubbed. A seal pattern with an injection port is formed on the lower substrate. A plurality of spacers are scattered on the lower substrate. The upper substrate and the lower substrate are **bonded** with each other. The **bonded** upper substrate and the lower substrate are cut. Liquid crystal is injected between the upper substrate and the lower substrate through the injection port.

ST liq crystal display manuf alignment film rubbing process

IT Liquid crystal displays

(method for manufacturing liquid crystal display)

L14 ANSWER 2 OF 4 CA COPYRIGHT 2005 ACS on STN

AN 141:251544 CA

ED Entered STN: 30 Sep 2004

TI High resolution and brightness full-color led display manufactured using chemical-mechanical polishing technique

IN Dai, Yuan-Tung; Peng, Yuan-Ching; Chen, Chien-Chih

PA Industrial Technology Research Institute, Taiwan

SO Taiwan., 7 pp.

CODEN: TWXXA5

DT Patent

LA Chinese

IC ICM H01L033-00

CC 74-13 (Radiation Chemistry, Photochemistry, and Photographic and Other Reprographic Processes)

Section cross-reference(s): 73, 76

FAN.CNT 1

PATENT NO.	KIND	DATE	APPLICATION NO.	DATE
PI TW 486830	B	20020511	TW 2001-90102754	20010208
PRAI TW 2001-90102754		20010208		

CLASS

PATENT NO.	CLASS	PATENT FAMILY CLASSIFICATION CODES
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TW 486830	ICM	H01L033-00
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AB A full-color LED **display** consists of red, green, and blue LED elements. Red and green LED elements are formed on a first substrate and

covered by a first buffer layer. A second substrate is **bonded** to the buffer layer and polished to a thin substrate layer on which a blue LED element is formed. Then, a second buffer layer covers all three LED elements to form a full-color LED device. By arranging multiple full-color LED devices in rows and columns, and addressing and controlling each LED device by suitable wires, electrode layer and **peripheral circuit**, it is able to form a full-color LED **display** with high resolution and brightness.

ST full color electroluminescent display fabrication; polishing chem mech fabrication electroluminescent display

IT Polishing
(chemical-mech.; high resolution and brightness full-color LED display manufactured using chemical-mech. polishing technique)

IT Electroluminescent devices
Semiconductor device fabrication
Semiconductor electroluminescent devices
(high resolution and brightness full-color LED display manufactured using chemical-mech. polishing technique)

L14 ANSWER 3 OF 4 CA COPYRIGHT 2005 ACS on STN

AN 132:116202 CA

ED Entered STN: 18 Feb 2000

TI Manufacture of semiconductor memory devices

IN Inoue, Yoshihiko; Yoshioka, Hiroshi; Ureshino, Kazuhisa; Ohara, Kazuaki; Mishima, Michihiro

PA Hitachi, Ltd., Japan; Hitachi Super LSI System Co., Ltd.; Renesas Technology Corp.

SO Jpn. Kokai Tokkyo Koho, 12 pp.
CODEN: JKXXAF

DT Patent

LA Japanese

IC ICM H01L027-108

ICS H01L021-8242; H01L021-3205; H01L021-8234; H01L027-088; H01L027-10

CC 76-3 (Electric Phenomena)

FAN.CNT 1

	PATENT NO.	KIND	DATE	APPLICATION NO.	DATE
PI	JP 2000031415	A2	20000128	JP 1998-200276	19980715
	JP 3583927	B2	20041104		
PRAI	JP 1998-200276		19980715		

CLASS

PATENT NO.	CLASS	PATENT FAMILY CLASSIFICATION CODES
JP 2000031415	ICM	H01L027-108
	ICS	H01L021-8242; H01L021-3205; H01L021-8234; H01L027-088; H01L027-10

AB Adjusting input/output capacitance value of the semiconductor device, to maximum and lowest standard or the request of the customer, adjust. Functions in

the principal plane of semiconductor substrate as the component separation territory the formation to do thick silicone oxide film, 1st electrode the formation is done on silicone oxide film of the **peripheral circuit** territory. 1st electrode is formed simultaneously with the gate electrode of the MISFETs for memory cell selection. 1st and 2nd electrodes, which are actually semiconductor substrates, constitute, along with Si oxide insulator films, parallel-plate-type capacitors. The 1st electrode is connected to the **bonding** pad of 3rd interconnection layer. Selection of connection to **bonding** pads is carried out by the modification of the patterns of metal **switching** parts.

ST semiconductor memory device MIS FET

IT Electric capacitance

Semiconductor device fabrication

Semiconductor memory devices

(adjustment of input/output capacitance in manufacture of semiconductor

memory devices)
IT MISFET (transistors)
(manufacture of semiconductor memory devices)
IT 7631-86-9, Silica, uses
RL: DEV (Device component use); USES (Uses).
(adjustment of input/output capacitance in manufacture of semiconductor memory devices)

L14 ANSWER 4 OF 4 CA COPYRIGHT 2005 ACS on STN

AN 127:286007 CA

ED Entered STN: 11 Nov 1997

TI Active matrix type liquid crystal display device and its manufacture

IN Inoue, Shunsuke; Okita, Akira

PA Canon K. K., Japan

SO Jpn. Kokai Tokkyo Koho, 6 pp.

CODEN: JKXXAF

DT Patent

LA Japanese

IC ICM G02F001-1343

ICS G02F001-136

CC 74-13 (Radiation Chemistry, Photochemistry, and Photographic and Other Reprographic Processes)

FAN.CNT 1

PATENT NO.	KIND	DATE	APPLICATION NO.	DATE
JP 09244045	A2	19970919	JP 1996-56063	19960313
PRAI JP 1996-56063		19960313		

CLASS

PATENT NO.	CLASS	PATENT FAMILY CLASSIFICATION CODES
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JP 09244045	ICM	G02F001-1343
	ICS	G02F001-136

AB In the liquid-crystal **display** device comprising a liquid-crystal layer enclosed between a substrate equipped with image **display** units containing a **switching** element and peripheral circuits for sending signals to the **display** units, and another substrate bearing a transparent electrode, an electrode layer of the type used for the pixel electrode in each **display** unit is also formed on the **bonding** pad of the **peripheral circuit**. Also claimed is a method for manufacturing the above liquid-crystal **display** device. The properties of the **switching** elements are improved.

ST active matrix liq crystal display; **bonding** pad liq crystal display

IT Liquid crystal displays

(active matrix type liquid crystal display device and its manufacture)

WEST Search History

DATE: Thursday, July 21, 2005

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END OF SEARCH HISTORY